

# Abstracts

## Scattering Parameter Measurement Techniques in Microstrip

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J.L. Schallenberg and J.C. Beal. "Scattering Parameter Measurement Techniques in Microstrip." 1972 G-MTT International Microwave Symposium Digest of Technical Papers 72.1 (1972 [MWSYM]): 27-29.

Measurements are made on microstrip waveguides with coaxial-to-microstrip wave transitions, by means of a sliding obstacle method, and S-parameters of the transitions and the microstrip are derived for a range of frequencies from 1 to 11 GHz.

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